

<b>Notice of References Cited</b>		Application/Control No. 10/553,696	Applicant(s)/Patent Under Reexamination KATOH ET AL.	
		Examiner Martin J. Angebranndt	Art Unit 1795	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0170119 A1	09-2004	Watanabe, Hidetoshi	369/286
*	B	US-2003/0068513 A1	04-2003	Kubota et al.	428/500
*	C	US-7,005,174 B2	02-2006	Yamasaki et al.	428/64.1
*	D	US-5,942,578	08-1999	Noguchi et al.	525/228
*	E	US-6,398,892	06-2002	Noguchi et al.	156/85
*	F	US-6,465,330	10-2002	Takahashi et al.	438/464
*	G	US-2004/0019127	01-2004	Yamamoto, Shouji	522/39
*	H	US-6,656,819	12-2003	Sugino et al.	438/460
*	I	US-2004/0020338	02-2004	Ookawa, Yuuji	83/13
J	US-				
K	US-				
L	US-				
M	US-				

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2002-241711	08-2002	Japan	Dobashi et al.	***
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.